

SFR9224TM-VB Datasheet

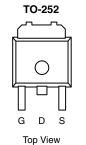
Power MOSFET

PRODUCT SUMMARY				
V _{DS} (V)	- 250			
R _{DS(on)} (Ω)	V _{GS} = - 10 V	1.0		
Q _g (Max.) (nC)	38			
Q _{gs} (nC)	8.0			
Q _{gd} (nC)	18			
Configuration	Single			

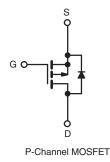
FEATURES

- Advanced Process Technology
- Dynamic dV/dt Rating
- 150 °C Operating Temperature
- · Fast Switching
- P-Channel
- · Fully Avalanche Rated
- Lead (Pb)-free Available





Drain Connected to Tab



ABSOLUTE MAXIMUM RATINGS	[−] _C = 25 °C, u	nless otherw	ise noted			
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V _{DS}	- 250	v	
Gate-Source Voltage			V _{GS}	± 20	v	
Continuous Drain Current	V at 10.V	$T_{C} = 25 \degree C$ $T_{C} = 100 \degree C$	- I _D -	- 6.0		
Continuous Drain Current	VGS at - TO V	T _C = 100 °C		- 4.0	A	
Pulsed Drain Current ^a			I _{DM}	- 16		
Linear Derating Factor				0.28	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	520	mJ	
Repetitive Avalanche Current ^a			I _{AR}	- 4.1	A	
Repetitive Avalanche Energy ^a			E _{AR}	3.5	mJ	
Maximum Power Dissipation	mum Power Dissipation T _C = 25 °C		PD	85	W	
Peak Diode Recovery dV/dt ^c			dV/dt	- 5.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d		
Mounting Torque	6 22 or 1	6-32 or M3 screw		10	lbf ⋅ in	
Mounting rorque	0-32 OF WIS SCIEW			1.1	N · m	

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Starting T_J = 25 °C, L = 62 mH, R_G = 25 Ω , I_{AS} = - 4.1 A (see fig. 12). c. I_{SD} \leq - 4.1 A, dl/dt \leq - 640 A/µs, V_{DD} \leq V_{DS}, T_J \leq 150 °C. d. 1.6 mm from case.

* Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	65	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	3.6	C/W		

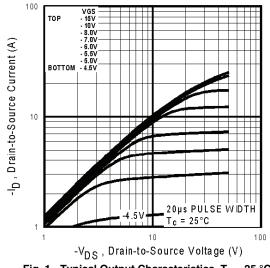
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} =	= 0 V, I _D = 250 μA	- 250	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_J$	Reference	se to 25 °C, $I_D = 1 \text{ mA}$	-	- 0.27	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	- V _{GS} , I _D = 250 μA	- 2.0	-	- 4.0	V
Gate-Source Leakage	I _{GSS}		V _{GS} = ± 20 V	-	-	± 100	nA
Zarra Oata Malta na Duain Ourrant	1	V _{DS} =	- 250 V, V _{GS} = 0 V	-	-	- 25	μA
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 200 V	V, V _{GS} = 0 V, T _J = 150 °C	-	-	- 250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = - 10 V	I _D = - 2.5 A ^b	-	1.0	-	Ω
Forward Transconductance	g _{fs}	V _{DS} =	- 50 V, I _D = - 4.1 A ^b	2.2	-	-	S
Dynamic							
Input Capacitance	C _{iss}		V _{GS} = 0 V,		680	-	
Output Capacitance	C _{oss}		$V_{\rm DS} = -25 \rm V,$	-	170	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	0 MHz, see fig. 5	-	40	-	
Drain to Sink Capacitance	С		f = 1.0 MHz	-	12	-	
Total Gate Charge	Qg			-	-	38	
Gate-Source Charge	Q _{gs}	V _{GS} = - 10 V	$V_{GS} = -10 V$ $I_D = -4.1 A, V_{DS} = -200 V,$ see fig. 6 and 13 ^b		-	8.0	nC
Gate-Drain Charge	Q _{gd}		see lig. 6 and 13°	-	-	18	1
Turn-On Delay Time	t _{d(on)}			-	12	-	
Rise Time	t _r		130 V, I _D = - 4.1 A,	-	23	-	
Turn-Off Delay Time	t _{d(off)}	R _G = 12 Ω, R _D = 31 Ω, see fig. 10 ^b		-	34	-	- ns
Fall Time	t _f			-	21	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	
Internal Source Inductance	L _S			-	7.5	-	nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	۱ _S	showing the	MOSFET symbol showing the		-	- 4.1	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	- 16	A
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$I_{\rm S}$ = - 4.1 A, $V_{\rm GS}$ = 0 V ^b	-	-	- 6.5	V
Body Diode Reverse Recovery Time	t _{rr}	- $T_J = 25 \text{ °C}, I_F = -4.1 \text{ A}, \text{ dl/dt} = -100 \text{ A/}\mu\text{s}^b$		-	190	290	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.5	2.2	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L_S and L_D)					L _D)

Notes

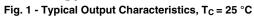
a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



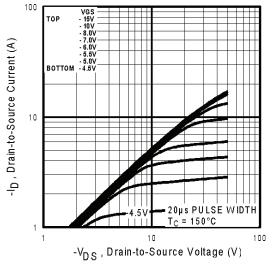
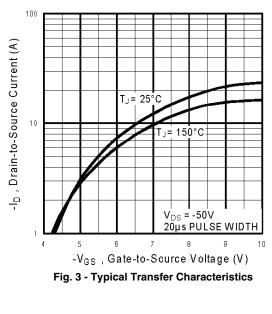


Fig. 2 - Typical Output Characteristics, T _C= 150 °C



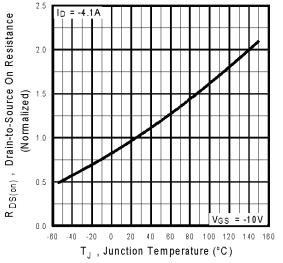


Fig. 4 - Normalized On-Resistance vs. Temperature

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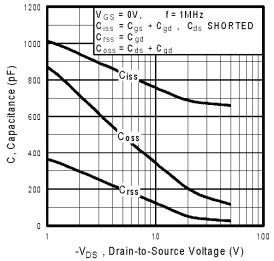


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

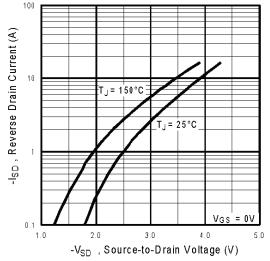


Fig. 7 - Typical Source-Drain Diode Forward Voltage

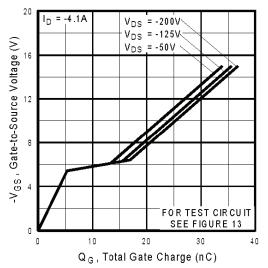


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

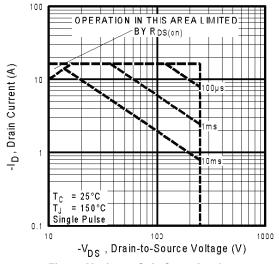


Fig. 8 - Maximum Safe Operating Area

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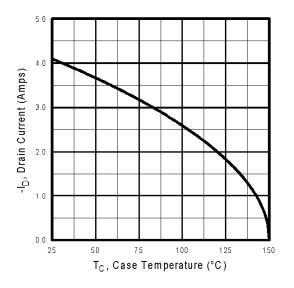


Fig. 9 - Maximum Drain Current vs. Case Temperature

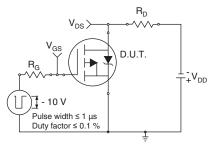


Fig. 10a - Switching Time Test Circuit

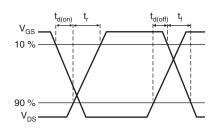
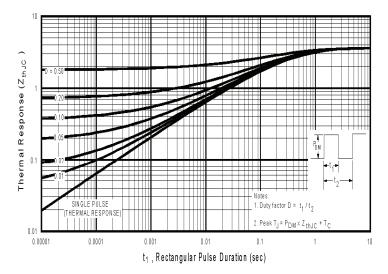


Fig. 10b - Switching Time Waveforms





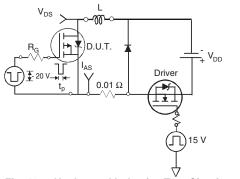


Fig. 12a - Unclamped Inductive Test Circuit

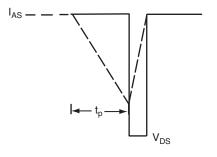


Fig. 12b - Unclamped Inductive Waveforms



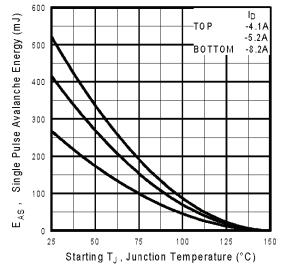


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

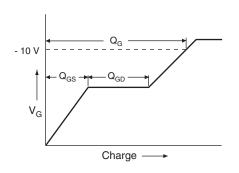


Fig. 13a - Basic Gate Charge Waveform

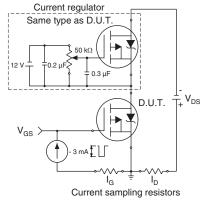
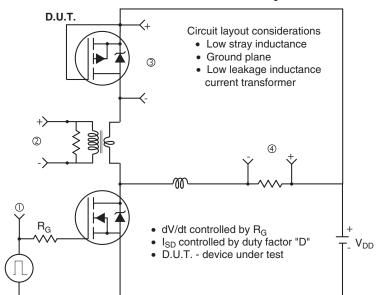


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit

• Compliment N-Channel of D.U.T. for driver

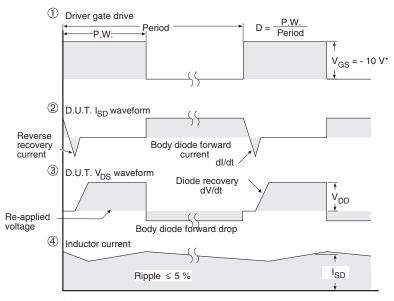
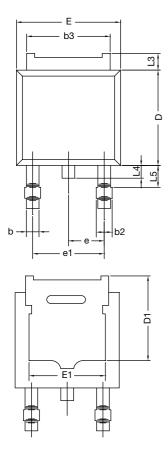


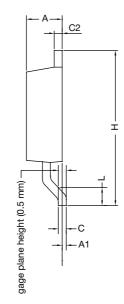


Fig. 14 - For P-Channel



TO-252AA CASE OUTLINE





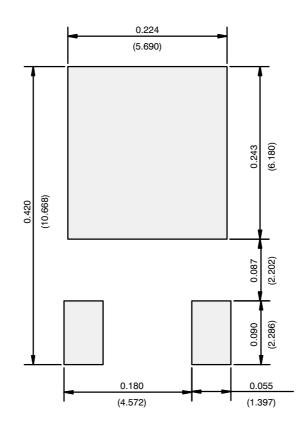
	MILLIMETERS		INC	HES	
DIM.	MIN.	MAX.	MIN.	MAX.	
А	2.18	2.38	0.086	0.094	
A1	-	0.127	-	0.005	
b	0.64	0.88	0.025	0.035	
b2	0.76	1.14	0.030	0.045	
b3	4.95	5.46	0.195	0.215	
С	0.46	0.61	0.018	0.024	
C2	0.46	0.89	0.018	0.035	
D	5.97	6.22	0.235	0.245	
D1	5.21	-	0.205	-	
E	6.35	6.73	0.250	0.265	
E1	4.32	-	0.170	-	
Н	9.40	10.41	0.370	0.410	
е	2.28	BSC	0.090 BSC		
e1	4.56 BSC		0.180 BSC		
L	1.40	1.78	0.055	0.070	
L3	0.89	1.27	0.035	0.050	
L4	-	1.02	-	0.040	
L5	1.14	1.52	0.045	0.060	
ECN: X12-0247-Rev. M, 24-Dec-12 DWG: 5347					

Note

• Dimension L3 is for reference only.



RECOMMENDED MINIMUM PADS FOR DPAK (TO-252)



Recommended Minimum Pads Dimensions in Inches/(mm)



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